1 OF 8 DEMULITPLEXER/DECODER (SELECTED OUTPUT IS HIGH)

10162F: -30 to $+85^{\circ} \mathrm{C}$, CERDIP

## DIGITAL 10,000 SERIES ECL

## FEATURES

- FAST PROPAGATION DELAY
$=4.0 \mathrm{~ns}$ TYP ADDRESS TO OUTPUT
$=4.5 \mathrm{~ns}$ TYP ENABLE TO OUTPUT
- LOW POWER DISSIPATION = 295 mW/PACKAGE TYP (NO LOAD)
- HIGH FANOUT CAPABILITY - CAN DRIVE EIGHT $50 \Omega$ LINES
- TRUE PARALLEL DECODER - ELIMINATES UNEQUAL DELAY TIMES
- HIGH IMMUNITY FROM POWER SUPPLY VARIA. TIONS: VEE $=-5.2 \mathrm{~V} \pm 5 \%$ RECOMMENDED
- HIGH Z INPUTS - INTERNAL 50 k $\Omega$ PULLDOWNS
- OPEN EMITTER OUTPUTS
- MEETS ECL 10,000 SERIES STANDARD INTERFACE SPECIFICATIONS


## APPLICATIONS

- 1 of 8 Decoder
- 1 line to 8 line Demultiplexer


## TRUTH TABLE

| INPUTS |  |  |  |  | OUTPUTS |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| E1 | EO | A2 | A1 | AO | D0 | D1 | D2 | D3 | D4 | D5 | D6 | D7 |
| L | L | L | L | L | H | L | L | L | L | L | L | L |
| L | L | L | L | H | L | H | L | L | L | L | L | L |
| L | L | L | H | L | L | L | H | L | L | L | L | L |
| L | L | L | H | H | L | L | L | H | L | L | L | L |
| L | L | H | L | L | L | L | L | L | H | L | L | L |
| L | L | H | L | H | L | L | L | L | L | H | L | L |
| L | L | H | H | L | L | L | L | L | L | L | H | L |
| L | L | H | H | H | L | L | L | L | L | L | L | H |
| H | L | ¢ | $\phi$ | $\phi$ | L | L | L | L | L | L | L | L |
| L | H | $\phi$ | $\phi$ | $\phi$ | L | L | L | L | L | L | L | L |
| H | H | $\phi$ | $\phi$ | $\phi$ | L | L | L | L | L | L | L | L |

$\phi=$ Doo't Care.

## TEMPERATURE RANGE

- -30 to $+85^{\circ} \mathrm{C}$ Operating Ambient

```
VCC1 = 1, VCC2 = 16, VEE = 8
POSITIVE LOGIC: HIGH LEVEL = '1'
```


## ELECTRICAL CHARACTERISTICS

(at Listed Voltages and Ambient Temperatures).

| $\begin{array}{r} \text { @ Test } \\ \text { Teinpertiture } \\ -\mathbf{3 0}{ }^{\circ} \mathbf{C} \\ +25^{\circ} \mathbf{C} \\ +85^{\circ} \mathrm{C} \end{array}$ |  | TEST VOLTAGE VALUES |  |  |  |  | $\begin{gathered} \mathbf{I V}_{\mathbf{c c}} \mathbf{o n d}^{\prime} \end{gathered}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | (Volts) |  |  |  |  |  |
|  |  | $V_{\text {IH max }}$ | $V_{1 L}$ min | $V_{\text {IHA }}$ min | $V_{\text {ILA }}$ max | VEE |  |
|  |  | 0.890 | -1.880 | -1.205 | -1.600 | -5.2 |  |
|  |  | 0.810 | -1.850 | -1.105 | -1.475 | -5.2 |  |
|  |  | 0.700 | $-1.825$ | -1.035 | -1.440 | -52 |  |
|  | Unit | TEST VOLTAGE APPLIED TOPINS LISTED BELOW: |  |  |  |  |  |
| Max |  | $V_{\text {IH max }}$ | VIL min | VIHA min | $V_{\text {ILA max }}$ | VeE |  |
| - | madc | - | - | - | - | 8 | 1,16 |
| - | $\mu \mathrm{Adc}$ | 14 | - | - | - | 8 | 1.16 |
| - | $\mu \mathrm{Adc}$ | - | 14 | - | - | 8 | 1.16 |
| -0.700 | Voc | 14 | - | - | - | 8 | 1,16 |
| -1.815 | Vac | 2 | - | - | - | 8 | 1.16 |
| -1.615 | Vde | 15 | - | - | - | 8 | 1.16 |
| - | Vdc | - | - | 14 | - | 8 | 1.16 |
| $\begin{aligned} & -1.695 \\ & -1.995 \end{aligned}$ | Vde Vac | - | - | $\begin{gathered} 2 \\ 15 \end{gathered}$ | - | 8 | $\begin{aligned} & 1,16 \\ & 1,16 \end{aligned}$ |
|  | n |  |  | Puise in | Pulse Out | -3.2 V | +2.0 V |
| - |  | - | - | 14 | $1_{1}^{13}$ | 8 | 1.16 |
| - |  | - | - |  |  |  |  |
| _ |  |  |  |  |  |  |  |

- Unused outputs connacted to $\mathbf{5 0}$. hm resistor to ground.

SWITCHING TIME TEST CIRCUIT


PROPAGATION DELAY WAVEFORMS @ $25^{\circ} \mathrm{C}$


NOTES:

1. Each ECL $\mathbf{1 0 , 0 0 0}$ series device has been designed to meet the DC specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 fpm is maintained. Voltage levels will shift approximately 5 mV with an air flow of 200 linear fpm. Outputs are terminated through a 50 -ohm resistor to $\mathbf{- 2 . 0}$ volts.
2. For $A C$ tests, all input and output cables to the scope are equal lengths of 50 -ohm coaxial cable. Wire length should be $<1 / 4$ inch from $T P_{\text {in }}$ to input pin and $T P_{\text {out }}$ to output pin. A $50-\mathrm{ohm}$ termination to ground is located in each scope input. Unused outputs are connected to a $\mathbf{5 0} \mathbf{0} \mathbf{- h m}$ resistor to ground.
3. Test procedures are shown for only one input or set of input conditions. Other inputs are tested in the same manner.
4. All voltage measurements are referenced to the ground terminal. Terminals not specifically referenced are left electrically open.
